

600V N-Channel MOSFET

General Features

- **Advanced Planar Process**
- $R_{DS(ON),typ.}$ =250 m Ω @ V_{GS} =10V
- Low Gate Charge Minimize Switching Loss
- Rugged Poly silicon Gate Structure

Absolute Maximum Ratings

Applications

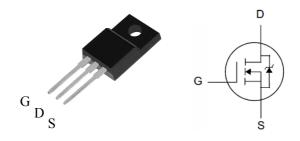
- **BLDC Motor Driver**
- Electric Welder
- **High Efficiency SMPS**

Ordering Information

Part Number	Package	Brand
PTA26N60	TO-220F	Z

Lead Free Package and Finish

BV _{DSS}	R _{DS(ON),typ.}	I _D
600V	250mΩ	26A



TO-220F Package

T_C=25 [°]C unless otherwise specified

Symbol	Parameter	PTA26N60	Unit	
V_{DSS}	Drain-to-Source Voltage	600	V	
V _{GSS}	Gate-to-Source Voltage	±30	V	
1	Continuous Drain Current	26		
I _D	Continuous Drain Current @ Tc=100℃	17	Α	
I _{DM}	Pulsed Drain Current at V _{GS} =10V ^[2,4]	104	7	
E _{AS}	Single Pulse Avalanche Energy	1500	mJ	
dv/dt	Peak Diode Recovery dv/dt ^[3]	5.0	V/ns	
n	Power Dissipation	88	W	
P_D	Derating Factor above 25℃	0.70	W/℃	
T _L T _{PAK}	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260	$^{\circ}$	
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 150		

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	PTA26N60	Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	1.42	20.22
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	100	℃ /W



Electrical Characteristics

OFF Characteristics T_J =25 °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	600			٧	V _{GS} =0V, I _D =250uA
I _{DSS} Drain-to-Source Leakage Current	Design to Course Leadings Courset			1		V _{DS} =600V, V _{GS} =0V
			125	uA	V_{DS} =480V, V_{GS} =0V, T_J =125 $^{\circ}$ C	
	Gate-to-Source Leakage Current +100 nA	nΛ	V _{GS} =+30V, V _{DS} =0V			
I _{GSS}				-100	I IIA	V _{GS} =-30V, V _{DS} =0V

ON Characteristics

T_J =25 °C unless otherwise specified

13 20				, 2000	inicoo otrici wioc opcomed	
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance		250	350	mΩ	V _{GS} =10V, I _D =13A
$V_{\text{GS(TH)}}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}=V_{GS}$, $I_{D}=250uA$
g FS	Forward Transconductance		32		S	V _{DS} =25V, I _D =13A

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		4.28			\/ =0\/
C _{rss}	Reverse Transfer Capacitance		0.19		nF	V_{GS} =0V, V_{DS} =25V, f =1.0MH $_{Z}$
C _{oss}	Output Capacitance		1.41			
Q_g	Total Gate Charge		78			
Q_{gs}	Gate-to-Source Charge		21		nC	V_{DD} =300V, I_{D} =26A, V_{GS} =0 to 10V
Q_{gd}	Gate-to-Drain (Miller) Charge		20			

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		25			
trise	Rise Time		39		20	V _{DD} =300V, I _D =13A,
td(OFF)	Turn-Off Delay Time		100		nS	V_{GS} = 10V RG=10 Ω
tfall	Fall Time		36			



Source-Drain Body Diode Characteristics

 T_J =25 $^{\circ}$ C unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I _{SD}	Continuous Source Current ^[2]		1	26	^	Integral PN-diode in
I _{SM}	Pulsed Source Current ^[2]			104	Α	MOSFET
V _{SD}	Diode Forward Voltage		-	1.5	V	I _S =28A, V _{GS} =0V
trr	Reverse recovery time		535		ns	V _{GS} =0V ,I _F =28A,
Qrr	Reverse recovery charge		4.6		uC	dir/dt=100A/µs

Note:

^[1] T_J=+25 $^{\circ}$ C to +150 $^{\circ}$ C .

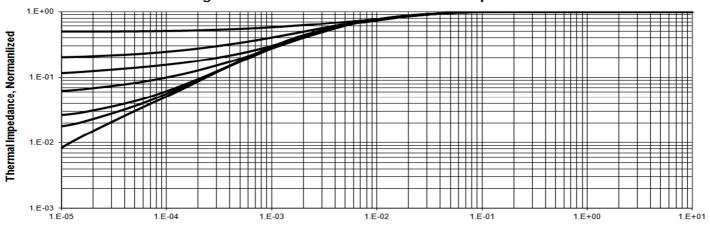
^[2] Silicon limited current only.

^[2] Silicon inflitted current only.
[3] Package limited current.
[4] Repetitive rating; pulse width limited by maximum junction temperature.
[5] Pulse width≤380µs; duty cycle≤2%.



Typical Characteristics

Figure 1. Maximum Transient Thermal Impedance



Rectangular Pulse Duration, Seconds

Figure 2. Max. Power Dissipation vs Case Temperature

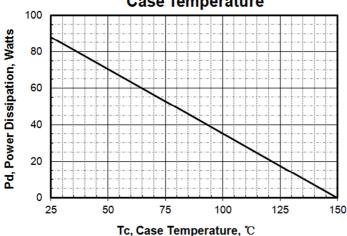


Figure 3 .Maximum Continuous Drain Current vs Tc

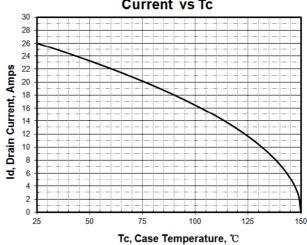


Figure 4. Output Characteristics

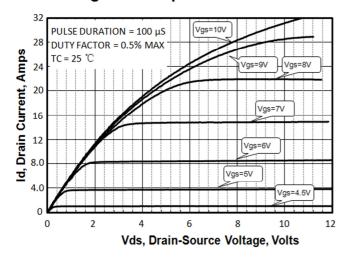
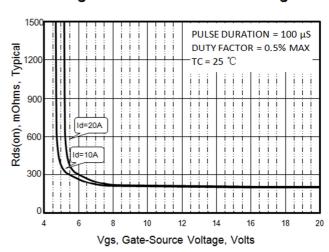


Figure 5. Rdson vs Gate Voltage





Typical Characteristics(Cont.)

Figure 6. Peak Current Capability

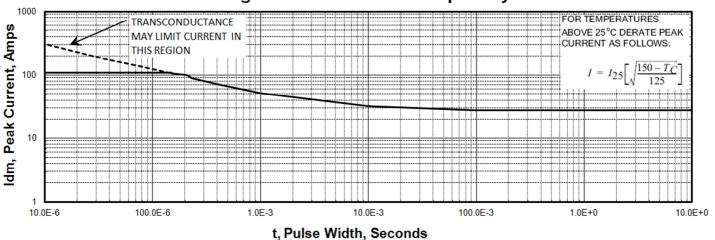


Figure 7. Transfer Characteristics

PULSE DURATION = 10 μS

12

DUTY FACTOR = 0.5% MAX

VDS=30V

4.0

3.0

4.0

5.0

6.0

7.0

8.0

Vgs, Gate to Source Voltage, Volts

Figure 9. Drain to Source ON Resistance vs Drain Current

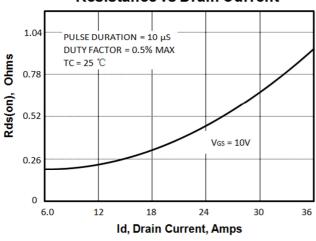


Figure 8. Unclamped Inductive Switching

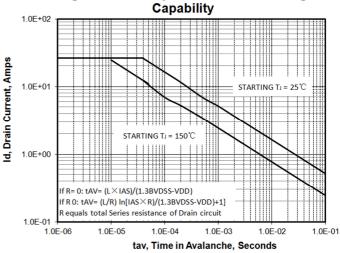
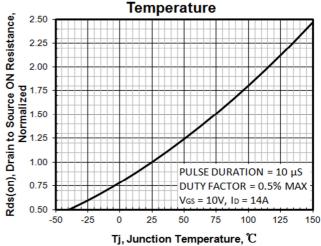


Figure 10. Rdson vs Junction Temperature





Typical Characteristics(Cont.)

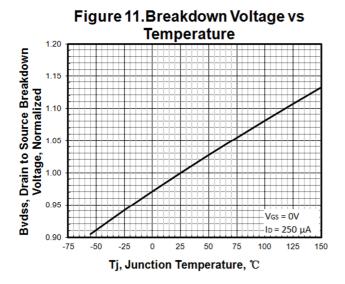


Figure 13. Maximum Safe Operating Area

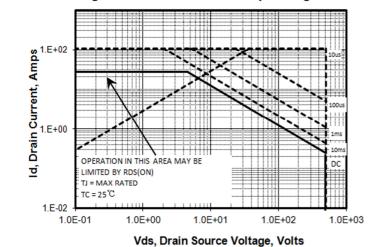


Figure 15 . Typical Gate Charge

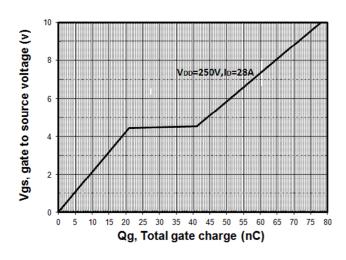


Figure 12. Threshold Voltage vs
Temperature

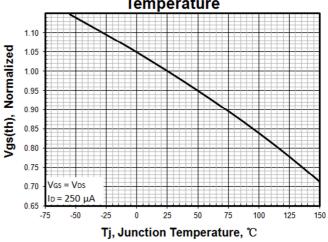


Figure 14. Capacitance vs Vds

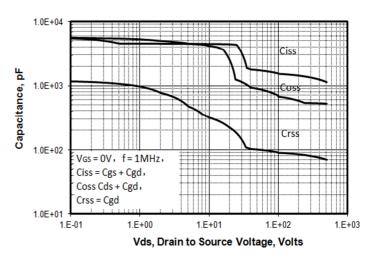
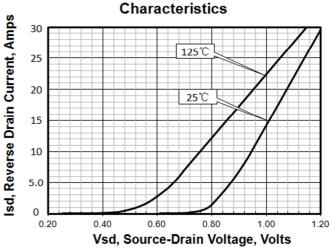


Figure 16.Body Diode Transfer





Test Circuits and Waveforms

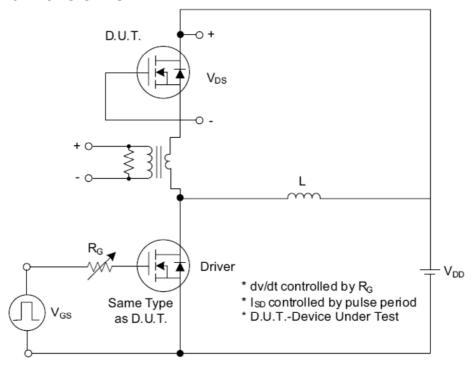


Fig. 1.1 Peak Diode Recovery dv/dt Test Circuit

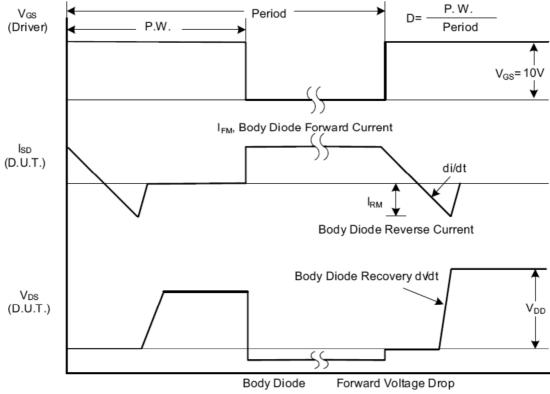


Fig. 1.2 Peak Diode Recovery dv/dt Waveforms



Test Circuits and Waveforms (Cont.)

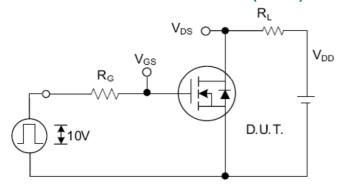


Fig. 2.1 Switching Test Circuit

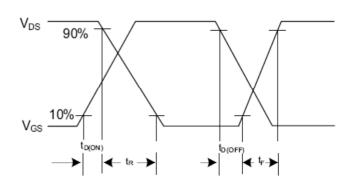


Fig. 2.2 Switching Waveforms

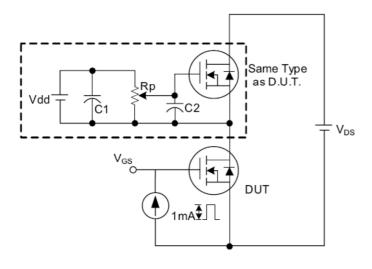


Fig. 3 . 1 Gate Charge Test Circuit

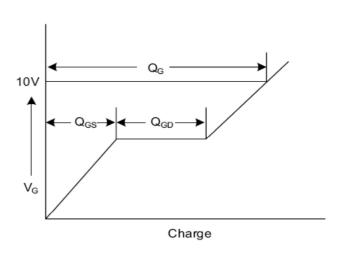


Fig. 3.2 Gate Charge Waveform

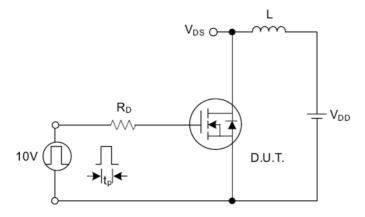


Fig. 4.1 Unclamped Inductive Switching Test Circuit

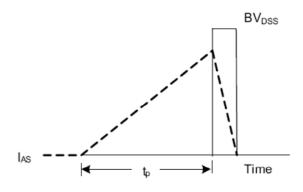


Fig. 4.2 Unclamped Inductive Switching Waveforms



Disclaimers:

Perfect Intelligent Power Semiconductor Co., Ltd (PIP) reserves the right to make changes without notice in order to improve reliability, function or design and to discontinue any product or service without notice. Customers should obtain the latest relevant information before orders and should verify that such information is current and complete. All products are sold subject to PIP's terms and conditions supplied at the time of order acknowledgement.

Perfect Intelligent Power Semiconductor Co., Ltd warrants performance of its hardware products to the specifications at the time of sale, Testing, reliability and quality control are used to the extent PIP deems necessary to support this warrantee. Except where agreed upon by contractual agreement, testing of all parameters of each product is not necessarily performed.

Perfect Intelligent Power Semiconductor Co., Ltd does not assume any liability arising from the use of any product or circuit designs described herein. Customers are responsible for their products and applications using PIP's components. To minimize risk, customers must provide adequate design and operating safeguards.

Perfect Intelligent Power Semiconductor Co., Ltd does not warrant or convey any license either expressed or implied under its patent rights, nor the rights of others. Reproduction of information in PIP's data sheets or data books is permissible only if reproduction is without modification or alteration. Reproduction of this information with any alteration is an unfair and deceptive business practice. Perfect Intelligent Power Semiconductor Co., Ltd is not responsible or liable for such altered documentation.

Resale of PIP's products with statements different from or beyond the parameters stated by Perfect Intelligent Power Semiconductor Co., Ltd for that product or service voids all express or implied warrantees for the associated PIP's product or service and is unfair and deceptive business practice. Perfect Intelligent Power Semiconductor Co., Ltd is not responsible or liable for any such statements.

Life Support Policy:

Perfect Intelligent Power Semiconductor Co., Ltd's products are not authorized for use as critical components in life support devices or systems without the expressed written approval of Perfect Intelligent Power Semiconductor Co., Ltd.

As used herein:

- 1. Life support devices or systems are devices or systems which:
 - a. are intended for surgical implant into the human body,
 - b. support or sustain life,
 - c. whose failure to perform when properly used in accordance with instructions for used provided in the labeling, can be reasonably expected to result in significant injury to the user.
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by PIP manufacturer:

Other Similar products are found below:

614233C 648584F MCH3443-TL-E MCH6422-TL-E FDPF9N50NZ FW216A-TL-2W FW231A-TL-E APT5010JVR NTNS3A92PZT5G IRF100S201 JANTX2N5237 2SK2464-TL-E 2SK3818-DL-E FCA20N60_F109 FDZ595PZ STD6600NT4G FSS804-TL-E 2SJ277-DL-E 2SK1691-DL-E 2SK2545(Q,T) D2294UK 405094E 423220D MCH6646-TL-E TPCC8103,L1Q(CM 367-8430-0972-503 VN1206L 424134F 026935X 051075F SBVS138LT1G 614234A 715780A NTNS3166NZT5G 751625C 873612G IRF7380TRHR IPS70R2K0CEAKMA1 RJK60S3DPP-E0#T2 RJK60S5DPK-M0#T0 APT5010JVFR APT12031JFLL APT12040JVR DMN3404LQ-7 NTE6400 JANTX2N6796U JANTX2N6784U JANTXV2N5416U4 SQM110N05-06L-GE3 SIHF35N60E-GE3